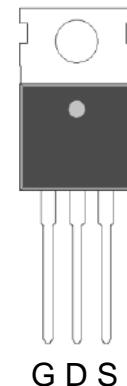


N-Channel Enhancement Mode Power MOSFET

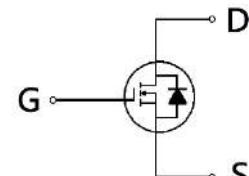
Features:

- Low On Resistance
- Low Gate Charge
- Fast Switching Characteristic

TO-220



| | |
|--|---------------|
| BV_{DSS} | 40V |
| $I_D @ V_{GS}=10V, T_c=25^\circ C$ (silicon limit) | 240A |
| $I_D @ V_{GS}=10V, T_c=25^\circ C$ (package limit) | 195A |
| $I_D @ V_{GS}=10V, T_A=25^\circ C$ | 25A |
| $R_{DS(ON)} \text{ typ. } @ V_{GS}=10V, I_D=50A$ | 1.4m Ω |



G : Gate S : Source D : Drain

Ordering Information

| Device | Package | Shipping |
|-----------|--|---|
| KE1D3N04B | TO-220 (Pb-free lead plating package) | 50 pcs/tube, 20 tubes/box, 5 boxes / carton |

Absolute Maximum Ratings ($T_A=25^\circ\text{C}$)

| Parameter | Symbol | Limits | Unit |
|---|-----------------------------------|----------|------|
| Drain-Source Voltage | V _{DS} | 40 | V |
| Gate-Source Voltage | V _{GS} | ±20 | |
| Continuous Drain Current @ V _{GS} =10V, T _C =25°C (silicon limit) | I _D | 240 | A |
| Continuous Drain Current @ V _{GS} =10V, T _C =25°C (package limit) | | 195 | |
| Continuous Drain Current @ V _{GS} =10V, T _C =100°C | | 170 | |
| Continuous Drain Current @ V _{GS} =10V, T _A =25°C | | 25 | |
| Continuous Drain Current @ V _{GS} =10V, T _A =70°C | | 20 | |
| Pulsed Drain Current | I _{DM} | 780 | mJ |
| Continuous Body Diode Forward Current @ T _C =25°C | I _S | 208 | |
| Avalanche Current @ L=0.1mH | I _{AS} | 100 | |
| Avalanche Energy @ L=0.5mH | E _{AS} | 625 | |
| Total Power Dissipation | T _C =25°C | *a | W |
| | T _C =100°C | *a | |
| | T _A =25°C | *b | |
| | T _A =70°C | *b | |
| Operating Junction and Storage Temperature Range | T _J , T _{Stg} | -55~+175 | °C |

Thermal Data

| Parameter | Symbol | Steady State | Unit |
|---|------------------|--------------|------|
| Thermal Resistance, Junction-to-case | R _{θJC} | 0.6 | °C/W |
| Thermal Resistance, Junction-to-ambient | R _{θJA} | 58 | |

Note:

- *a. The power dissipation P_D is based on T_{J(MAX)}=175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- *b. The value of R_{θJA} is measured with the device mounted on 1 in² FR -4 board with 2 oz. copper, in a still air environment with T_A=25°C. The power dissipation P_D is based on R_{θJA} and the maximum allowed junction temperature of 175°C. The value in any given application depends on the user's specific board design.
- *c. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175°C. Ratings are based on low frequency and low duty cycles to keep initial T_J=25°C.



Electrical Characteristics ($T_A=25^\circ\text{C}$, unless otherwise specified)

| Symbol | Min. | Typ. | Max. | Unit | Test Conditions | |
|---------------------------|------|------|------|------|--|--|
| Static | | | | | | |
| BV _{DSS} | 40 | - | - | V | V _{GS} =0V, I _D =250μA | |
| V _{GS(th)} | 2 | - | 4 | | V _{DS} =V _{GS} , I _D =250μA | |
| G _{FS} | - | 35.8 | - | S | V _{DS} =10V, I _D =20A | |
| I _{GSS} | - | - | ±100 | nA | V _{GS} =±20V, V _{DS} =0V | |
| I _{DSS} | - | - | 1 | μA | V _{DS} =32V, V _{GS} =0V | |
| R _{DSS(ON)} | - | 1.4 | 2 | mΩ | V _{GS} =10V, I _D =50A | |
| Dynamic | | | | | | |
| C _{iss} | - | 8750 | - | pF | V _{DS} =20V, V _{GS} =0V, f=1MHz | |
| C _{oss} | - | 1100 | - | | | |
| C _{rss} | - | 660 | - | | | |
| R _g | - | 2.5 | - | Ω | f=1MHz | |
| Q _g *1, 2 | - | 175 | - | nC | V _{DS} =20V, I _D =50A, V _{GS} =10V | |
| Q _{gs} *1, 2 | - | 39 | - | | | |
| Q _{gd} *1, 2 | - | 54 | - | | | |
| t _{d(ON)} *1, 2 | - | 40 | - | ns | V _{DS} =20V, I _D =50A, V _{GS} =10V, R _{GS} =1Ω | |
| t _r *1, 2 | - | 22 | - | | | |
| t _{d(OFF)} *1, 2 | - | 115 | - | | | |
| t _f *1, 2 | - | 35 | - | | | |
| Source-Drain Diode | | | | | | |
| V _{SD} *1 | - | 0.79 | 1.2 | V | I _S =30A, V _{GS} =0V | |
| t _{rr} | - | 33 | - | ns | I _F =30A, dI _F /dt=100A/μs | |
| Q _{rr} | - | 30 | - | nC | | |

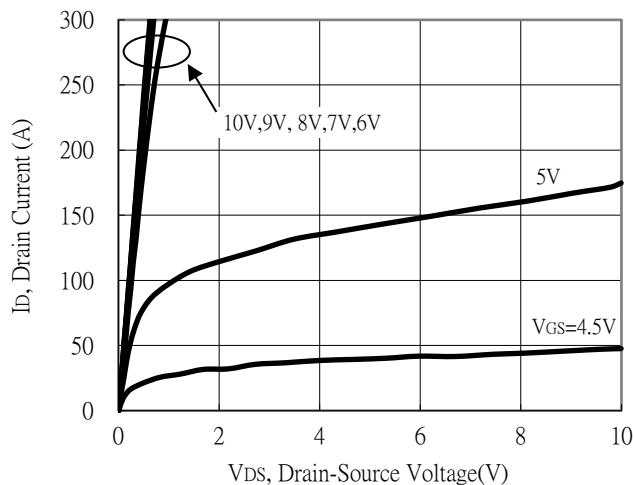
Note:

*1. Pulse Test : Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

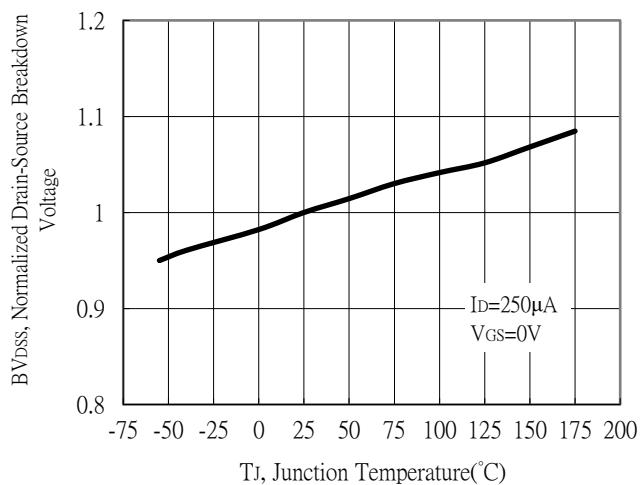
*2. Independent of operating temperature

Typical Characteristics

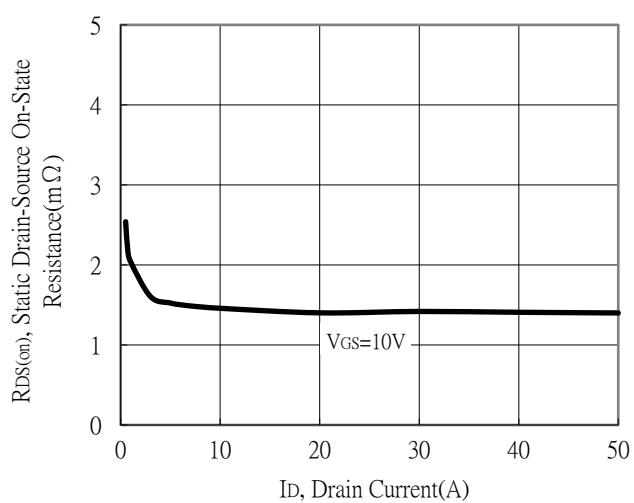
Typical Output Characteristics



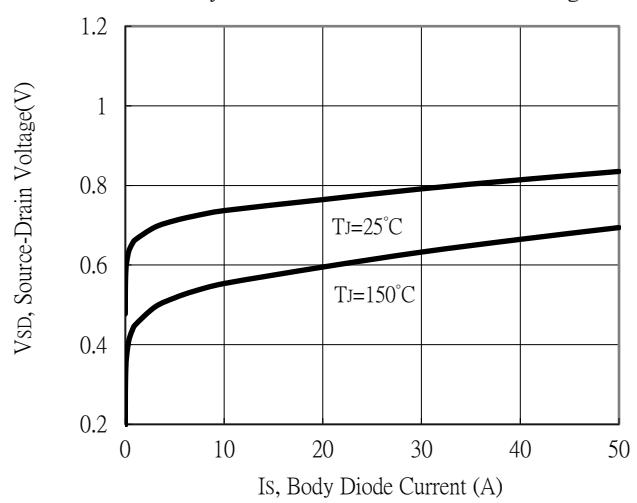
Breakdown Voltage vs Ambient Temperature



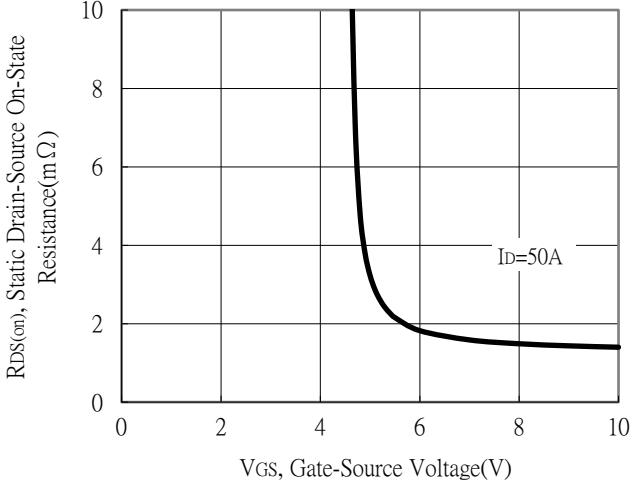
Static Drain-Source On-State resistance vs Drain Current



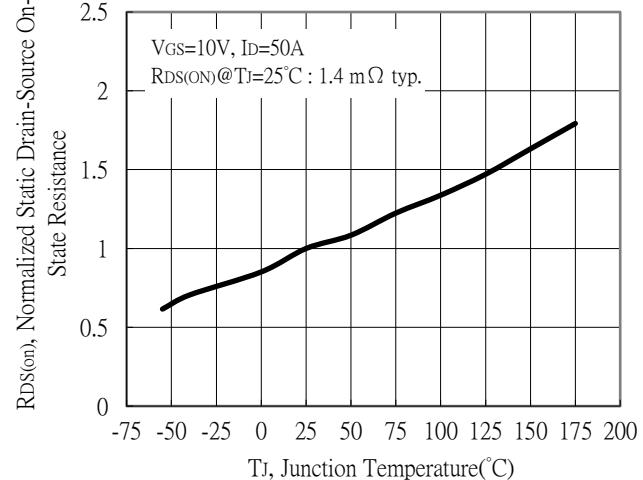
Body Diode Current vs Source-Drain Voltage



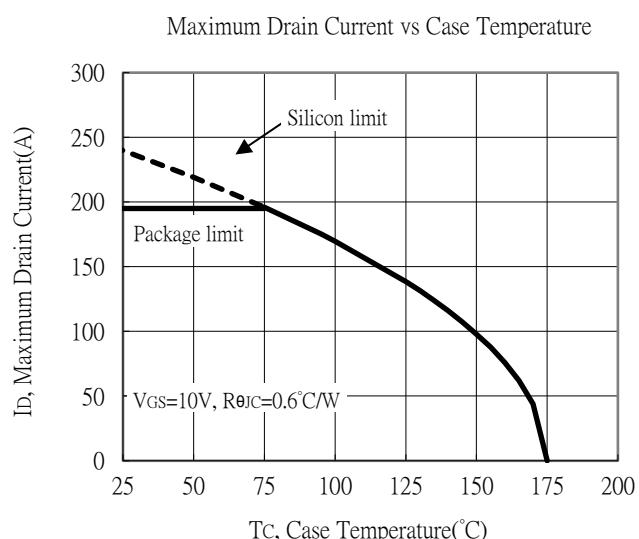
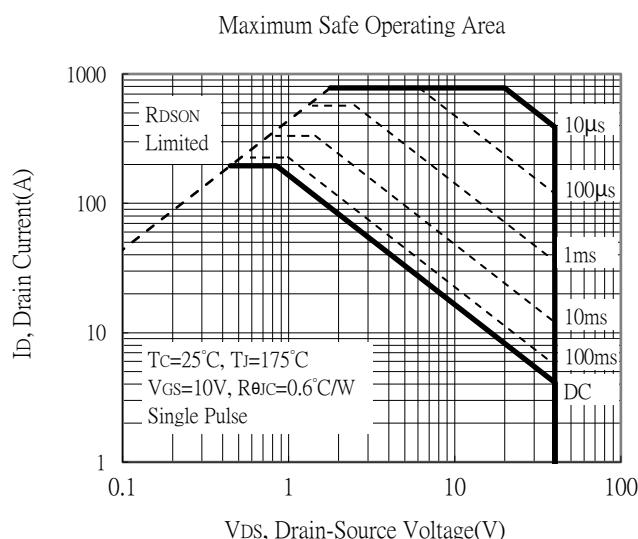
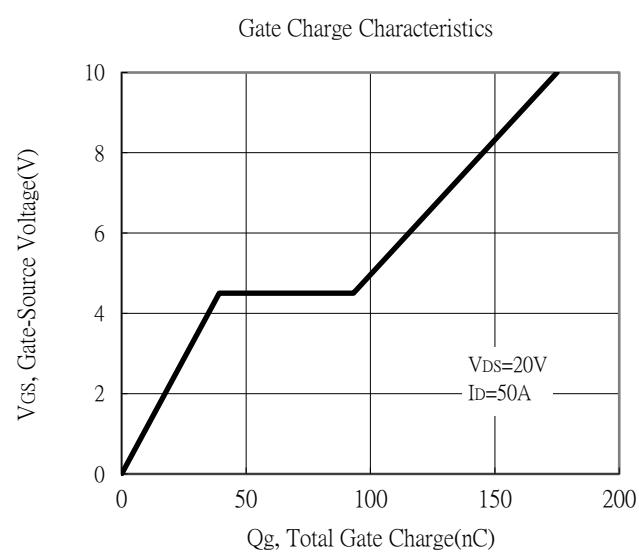
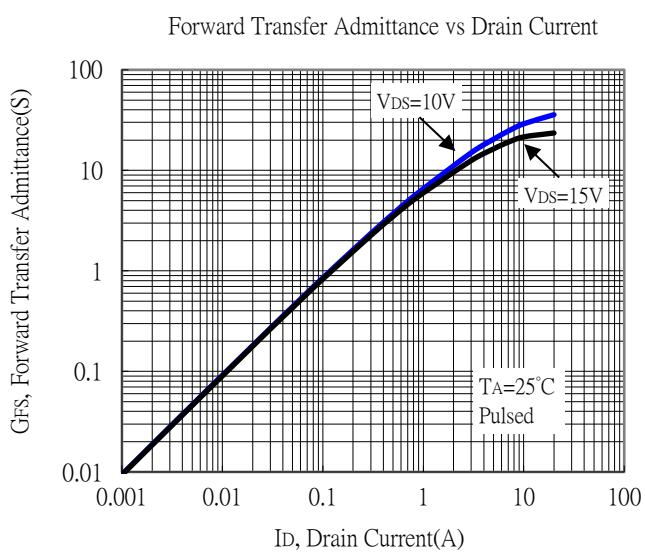
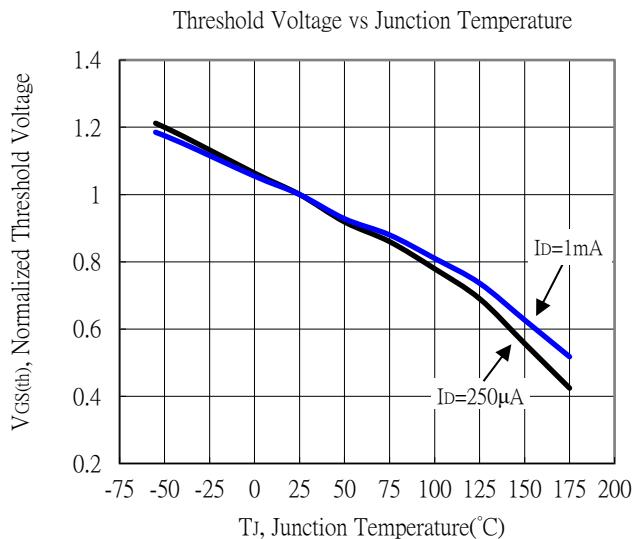
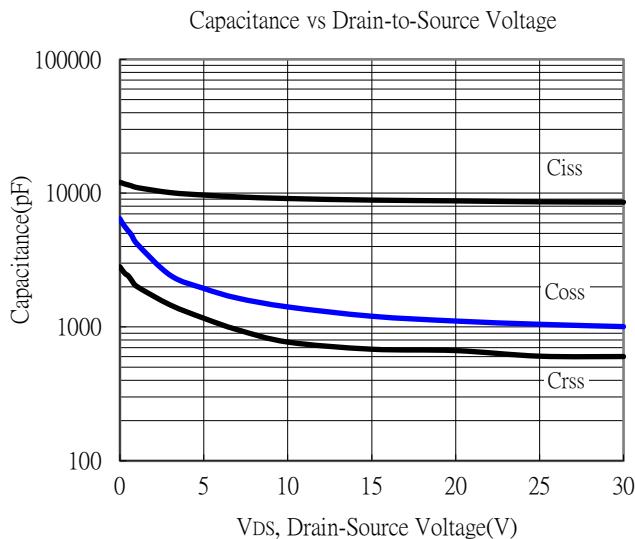
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Drain-Source On-State Resistance vs Junction Temperature

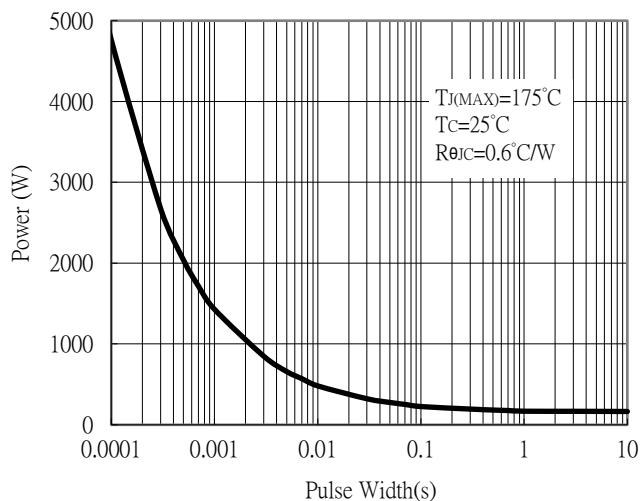


Typical Characteristics (Cont.)

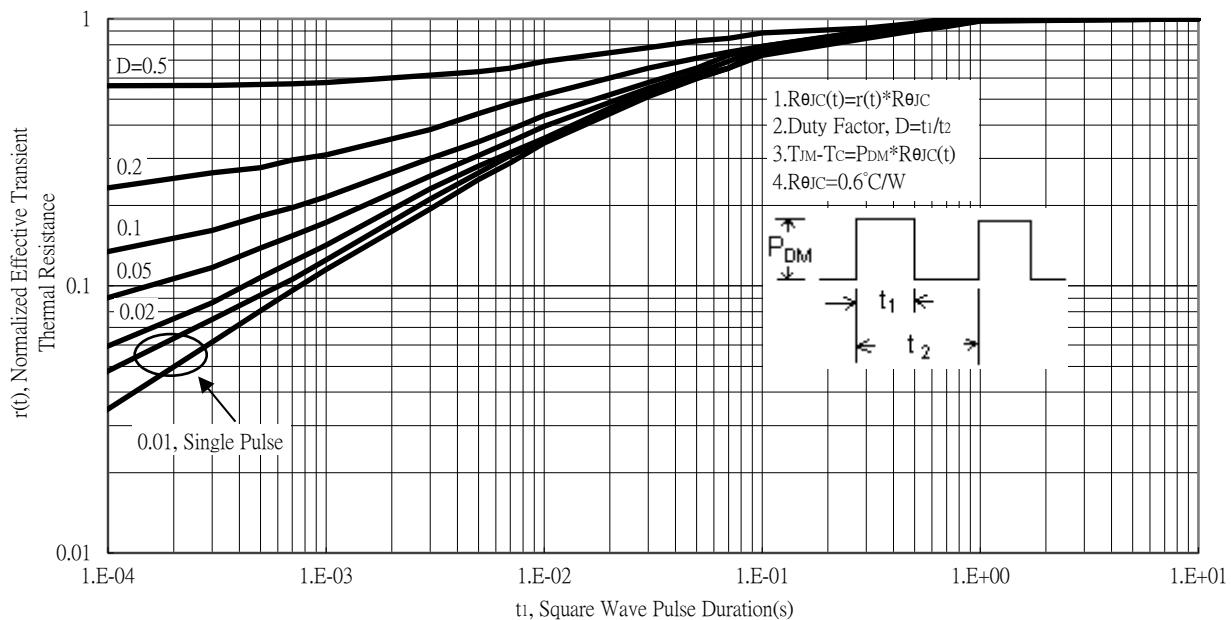


Typical Characteristics (Cont.)

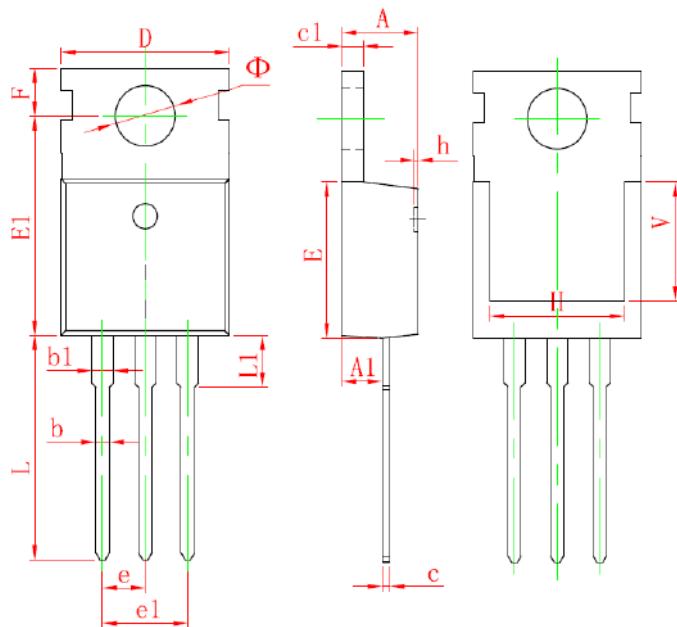
Single Pulse Power Rating, Junction to Case



Transient Thermal Response Curves

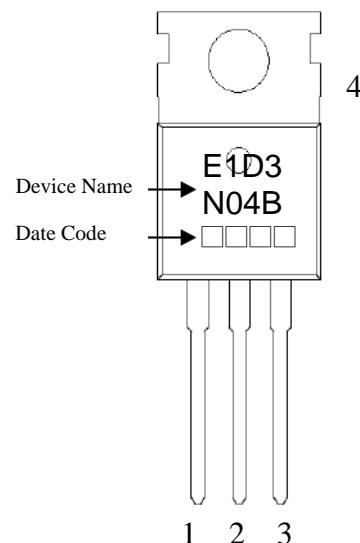


TO-220 Dimension



3-Lead TO-220 Plastic Package

Marking:



Style: Pin 1.Gate 2.Drain 3.Source
 4.Drain

*: Typical

| DIM | Millimeters | | Inches | | DIM | Millimeters | | Inches | |
|-----|-------------|--------|--------|-------|-----|-------------|--------|--------|-------|
| | Min. | Max. | Min. | Max. | | Min. | Max. | Min. | Max. |
| A | 4.400 | 4.600 | 0.173 | 0.181 | e | 2.540* | | 0.100* | |
| A1 | 2.250 | 2.550 | 0.089 | 0.100 | e1 | 4.980 | 5.180 | 0.196 | 0.204 |
| b | 0.710 | 0.910 | 0.028 | 0.036 | F | 2.650 | 2.950 | 0.104 | 0.116 |
| b1 | 1.170 | 1.370 | 0.046 | 0.054 | H | 7.900 | 8.100 | 0.311 | 0.319 |
| c | 0.330 | 0.650 | 0.013 | 0.026 | h | 0.000 | 0.300 | 0.000 | 0.012 |
| c1 | 1.200 | 1.400 | 0.047 | 0.055 | L | 12.900 | 13.400 | 0.508 | 0.528 |
| D | 9.910 | 10.250 | 0.390 | 0.404 | L1 | 2.850 | 3.250 | 0.112 | 0.128 |
| E | 8.950 | 9.750 | 0.352 | 0.384 | V | 6.900 | REF | 0.271 | REF |
| E1 | 12.650 | 13.050 | 0.498 | 0.514 | Φ | 3.600 | 3.800 | 0.142 | 0.150 |